



SYSTEM DEVELOPMENT OF IMAGE DATA AUGMENTATION USING GENERATIVE ADVERSARIAL NETWORK (GAN)

This report is submitted in accordance with requirement of the University Teknikal Malaysia Melaka (UTeM) for Bachelor Degree of Manufacturing Engineering (Hons.)



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Tajuk: **SYSTEM DEVELOPMENT OF IMAGE DATA AUGMENTATION USING GENERATIVE ADVERSARIAL NETWORK (GAN)**

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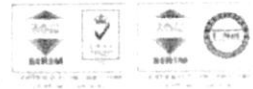
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Tajuk PSM: System development of image data augmentation using Generative Adversarial Network

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Sesi Pengajian: 2021/2022

Adalah saya dengan ini memperakui dan bersetuju bahawa Projek Sarjana Muda (PSM) yang bertajuk seperti di atas adalah merupakan satu projek yang dijalankan berdasarkan situasi sebenar yang berlaku di syarikat kami sepertimana yang telah dipersetujui bersama oleh wakil syarikat kami dan penyelia serta pelajar dari Fakulti Kejuruteraan Pembuatan, Universiti Teknikal Malaysia Melaka yang menjalankan projek ini.

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I hereby, declared this report entitled “System Development of Image Data Augmentation using Generative Adversarial Network (GAN)” is the result of my own research except as cited in references.

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APPROVAL

This report is submitted to the Faculty of Manufacturing Engineering of Universiti Teknikal Malaysia Melaka as a partial fulfilment of the requirement for Degree of Manufacturing Engineering (Hons). The member of the supervisory committee is as follow:



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ABSTRAK

Sebuah projek dicadangkan untuk menyiasat kegunaan Generative Adversarial Network (GAN) untuk menambah data imej demi mengatasi masalah kelas tidak seimbang dalam klasifikasi wafer silikon yang mempunyai kecacatan calar. Masalah kelas tidak seimbang ini disebabkan oleh bilangan sampel rosak yang kecil berbanding bilangan sampel yang elok dalam pembuatan. Mask GAN telah digunakan untuk menghasilkan imej label daripada input kotak sempadan. Seterusnya, imej label dimasukkan kepada Defect Image GAN untuk “melukis” kecacatan pada imej input yang elok. Kebolehlaksanaan system telah dikaji dengan mengukur ketepatan algoritma pembelajaran mesin yang dilatih dengan data janaan GAN. Di samping itu, rangkaian saraf yang dilatih dengan data janaan GAN dan data janaan kaedah konvensional telah dibandingkan. Sistem yang dicadangkan telah diuji dengan McNemar’s Test pada nilai keyakinan 95% dan menghasilkan peningkatan yang ketara berbanding kaedah konvensional.

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ABSTRACT

A project is proposed to investigate the use of Generative Adversarial Networks (GAN) to augment image data to overcome class imbalance problems in silicon wafer microcrack defect classification. This class imbalance problem is due to the small number of defective products compared to non-defective products in a production environment. A Mask GAN is used to generate images of defect mask label when bounding box information is supplied. The artificial defect masks are used by a Defect Image GAN to “paint” defects onto non-defect images. The system's feasibility is analyzed by evaluating the accuracy of the classifier trained on the augmented data, along with the number of misclassified images of defective products. Two identical classifier networks are trained on traditionally augmented data and GAN-augmented data and be compared. The system is shown with McNemar’s test with a confidence of 95%, to produce a significant improvement over conventional methods.

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DEDICATION

Dedicated to the joy of my family, Dolly.



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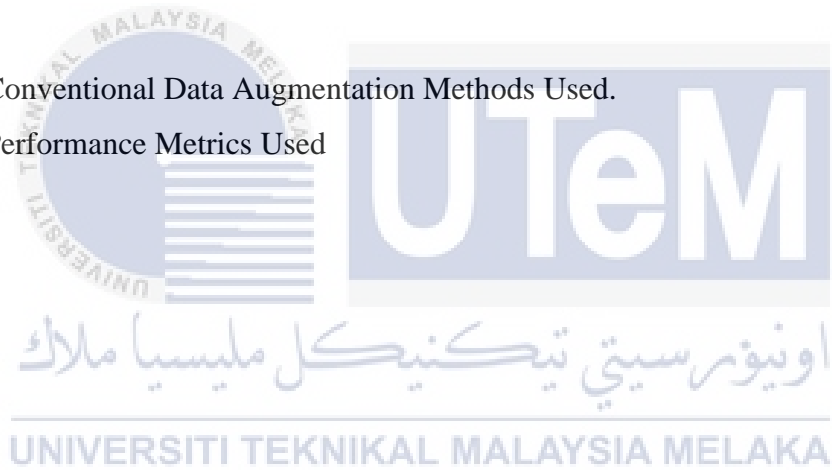
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LIST OF ABBREVIATIONS

CNN	Convolutional Neural Network
DCGAN	Deep Convolutional GAN
FID	Fréchet Inception Distance
GAN	Generative Adversarial Network



CHAPTER 1

INTRODUCTION

1.1 Project Background

This project is performed in collaboration with ViTrox Technologies Sdn. Bhd. ViTrox specializes in developing automated vision inspection system. Machine learning algorithms applied in their machine vision solutions aids their customers to ensure quality in their customer's production.

The presence of microcracks is one of the defects in silicon wafers. Microcrack refers to cracks with a thickness that is on the scale of micrometers. This type of defect is hard to be seen through the naked eye. Hence, computer vision-based solutions are the go-to in detecting microcracks in silicon wafers.

Image-based defect detection is a challenging problem requiring high accuracy algorithms and is often tackled using machine learning techniques. Deep convolutional neural networks are ubiquitous in image classification problems as they can produce results with high accuracy. In addition, convolutional neural networks effectively extract image features while numerous layers in deep neural networks greatly improve network performance by efficiently leveraging large amounts of training data (Krizhevsky et al., 2017).

Data augmentation is the process of manipulating training data to achieve better generalization. Common techniques in image data augmentation are "handcrafted", which include geometric transformations and noise filters (Shorten & Khoshgoftaar, 2019).

GAN is a framework of training two or more neural networks in a contest against each other to generate data that follows the distribution of the training set (Goodfellow et al., 2014). As seen in Figure 1.1, GAN consists of a generator network and a discriminator network. A generator network takes in random noise as input and produces images that mimic the training data. Meanwhile, a discriminator network is trained to distinguish between real and generated data. Iterations of training will result in both networks being more competent in their tasks, eventually producing generated data that closely resemble the training data. Hence, it is easy to see the implication of applying GAN in image data augmentation (Su, 2021).

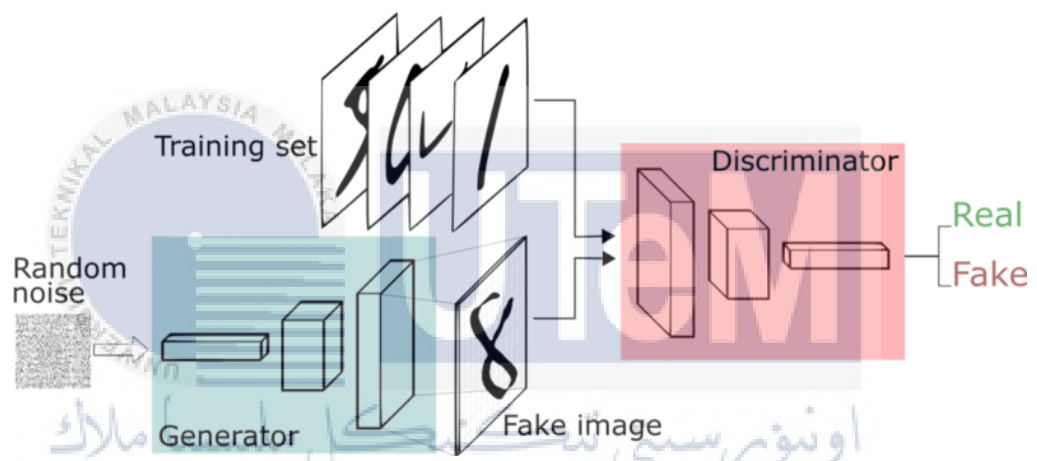


Figure 1.1: Architecture of a Typical GAN from (An Intuitive Introduction to Generative Adversarial Networks (GANs), 2018)

1.2 Problem Statement

In defect classification problems, non-defective samples are usually more abundant than defective samples. This phenomenon is also known as the class imbalance problem. As a result, the distribution of the minority class will be misrepresented, and the number of false negatives will increase (Buda et al., 2018). As seen in Figure 1.2, classifiers trained on imbalanced data tend to misclassify the minority class.

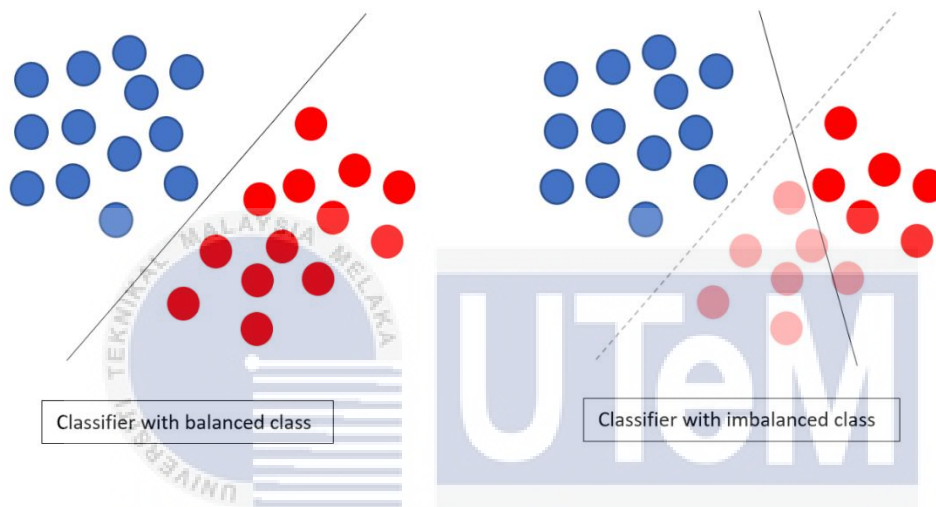


Figure 1.2: Visualization of the Class Imbalance Problem in Classification (Kushwaha, 2019).

Furthermore, misclassification of defective products as being non-defective is critically detrimental in defect detection applications. Data augmentation can be used to balance the data distribution while increasing data size. While the traditional "handcrafted" data augmentation technique is viable, it is specific to the image source and has to be manually tuned for each different source of the image. Hence, GAN is proposed as a generalizable solution to augment the minority samples and balance the data distribution.

1.3 Objectives

The project objectives are as follows:

- (a.) To produce a generalizable image data augmentation system for defect detection problems using GAN.
- (b.) To improve the accuracy of neural network-based defect detection algorithm by data augmentation using GAN.
- (c.) To analyze the impact of GAN-based data augmentation and traditional data augmentation on the performance of classification networks.

1.4 Scope

The project scopes are as follows:

- a. The proposed system will be evaluated on an image-based defect detection problem.
- b. Transfer learning will be used in training the classification network and GAN to avoid training the networks from scratch.
- c. Image under different conditions will be used to evaluate the generalizability of the proposed system.
- d. Traditional data augmentation techniques, including noise injection and geometric transformation, will be used as a benchmark for comparison in evaluating the performance of GAN-based data augmentation.

- e. The number of misclassified defective images by the classifier trained with augmented data will be used as a metric for the performance of the GAN.

1.5 Project Rationale

The project rationale are as follows:

- a. Data with imbalance class problem tend to affect machine learning model performance. This project aims to use data augmentation to overcome class imbalance by artificially generating samples of the minority class.
- b. Conventional data augmentation methods are chosen based on the characteristics of the input samples. GAN is proposed to automate the data augmentation step by learning image characteristics and generating artificial samples that are similar to input data.

1.6 Project Methodology

The project consists of using GAN as an alternate method of data augmentation. The role of GAN within the overall machine learning framework is shown in Figure 1.3.

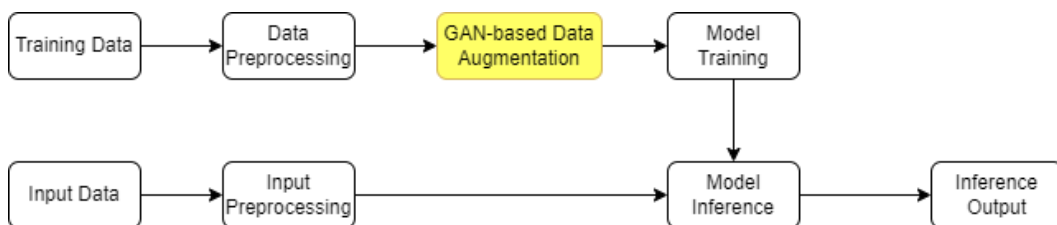


Figure 1.3: Overview of Project

Furthermore, the overall methodology of the project is summarized in the flowchart in Figure 1.4.

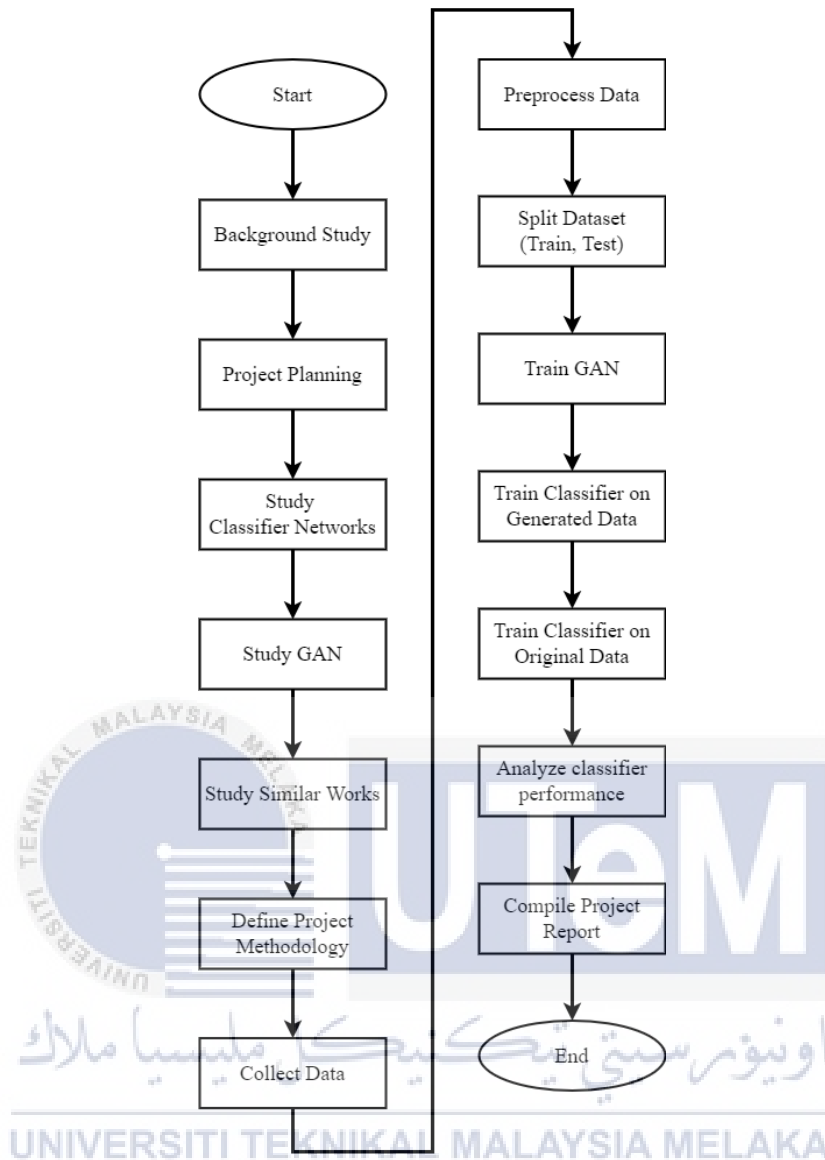


Figure 1.4: Flow Chart of the Proposed Project

After a preliminary background study is performed, an experiment will be conducted to evaluate the proposed system. First, image data collected and preprocessing such as resizing of the image will be done. The data will then be split into training and testing sets. Further, the training data will be used to train the GAN-based data augmentation system. Afterwards, two classifiers will be trained, with traditionally augmented data and GAN-augmented data. Finally, the rate of false negatives by these two classifiers will be compared to show the viability of GAN-based data augmentation.

1.7 Thesis Organization

This thesis is organized according to the 5 main chapters. Chapter 1 describes the project background, problem statement, objectives, scope, and rationale. Furthermore, literature on GAN and machine learning frameworks are reviewed in Chapter 2. In addition, project planning and experiment procedure is detailed in Chapter 3. Moreover, Chapter 4 analyzes results obtained from the experiments. Finally, the project is concluded in Chapter 5.



CHAPTER 2

LITERATURE REVIEW

2.1 Image Classification Problem

Image classification is a class of machine learning problem that involves taking in an image as input and determining the class that the image belongs to (Russakovsky et al., 2015). For example, insect image classification involves determining the type of insect in each image within the dataset, as shown in Figure 2.1.

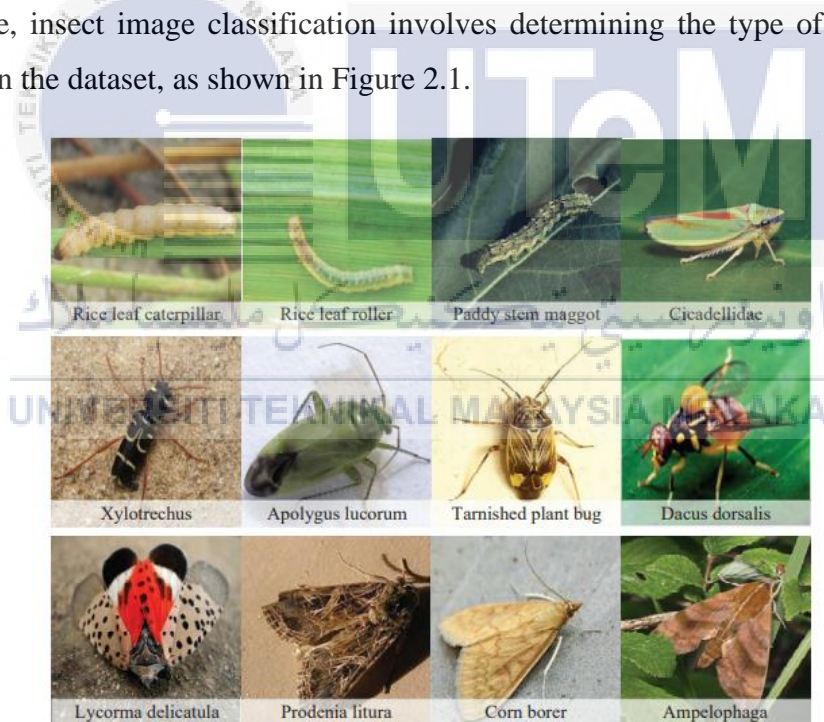


Figure 2.1: Samples from insect classification dataset (Wu et al., 2019).